Notice of References Cited

Application/Control No. 09/512,336	Reexamination	Applicant(s)/Patent Under Reexamination FUKUDA, SEIICHI		
Examiner	Art Unit			
Kin-Chan Chen	1765	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,846,886	12-1998	Hattori et al.	438/740
	В	US-5,024,722	06-1991	Cathey, Jr., David A.	438/695
	С	US-			
	D	US			
	Е	US-			
	F	US-			
	G	US-		`	
	Н	US-			
	ı	US-			
	j	US-			
	к	US-			
	L	US-			
	М	US-			

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
,	w	
-	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.